#### REMARKS

The Office Action dated May 6, 2004, has been received and reviewed.

Claims 1 through 20 are currently pending in the above-referenced application.

Claim 10 has been withdrawn from consideration as being directed to a non-elected species of invention.

Each of claims 1 through 9 and 11 through 20 has been considered and currently stands rejected.

Reconsideration of the above-referenced application is respectfully requested.

### Rejections Under 35 U.S.C. § 112, First Paragraph

Claims 1 through 9 and 11 through 20 are rejected under 35 U.S.C. § 112, first paragraph, based on the allegation that the specification of the above-referenced application does not provide an adequate written description of the subject matter recited in any of these claims.

Specifically, it has been asserted that the specification of the above-referenced application does not provide support for the recitations of "temporary electrical contact" in independent claims 1 and 8.

M.P.E.P. § 2173.05(e) provides:

There is no requirement that the words in [a] claim must match those used in [a] specification disclosure. Applicants are given a great deal of latitude in how they choose to define their invention so long as the terms and phrases used define the invention with a reasonable degree of clarity and precision.

While the specification of the above-referenced application does not use the term "temporary electrical contact," as recited in independent claims 1 and 8, one of ordinary skill in the art would readily understand that use of the specification of the above-referenced application provides numerous examples of methods for establishing temporary electrical contact. In particular, the specification of the above-referenced application provides examples of testing and stressing semiconductor devices. *See, e.g.*, paragraphs [0011], [0014], [0038].

One of ordinary skill in the art would immediately recognize that temporary electrical connections may be made in testing and stressing processes, as the tested or stressed

semiconductor devices will be subsequently disassembled from test or stress equipment, then set aside for permanent assembly into an electronic device.

Accordingly, it is respectfully submitted that claims 1 through 9 and 11 through 20 comply with the written description requirement of 35 U.S.C. § 112, first paragraph, and requested that the 35 U.S.C. § 112, first paragraph, rejection of these claims be withdrawn.

### Rejections Under 35 U.S.C. § 112, Second Paragraph

Claims 1 through 9 and 11 through 20 are rejected under 35 U.S.C. § 112, second paragraph, for reciting subject matter which is purportedly indefinite.

In particular, the Office has asserted that one of ordinary skill in the art would not understand the difference between a "temporary electrical contact," as recited in independent claims 1 and 8, and a permanent electrical contact.

It is respectfully submitted that one of ordinary skill in the art would recognize the difference between a temporary electrical contact and a permanent electrical contact. By way of example, without limiting the scope of any of claims 1 through 9 and 11 through 20, one of ordinary skill in the art would recognize that a temporary electrical contact is a reversible contact, such as the types that may be employed during testing or stressing (*i.e.*, burn-in) of semiconductor devices. In contrast, one of ordinary skill in the art would understand that a permanent electrical contact is a type of contact that is not intended to be reversed, such as when solder balls or other permanent connective elements are used to secure a semiconductor device to a carrier (*e.g.*, a circuit board).

U.S. Patent 6,370,766 to Degani et al. (hereinafter "Degani") evidences the fact that one of ordinary skill in the art would understand the difference between temporary and permanent electrical contacts. At col. 4, lines 9-20, Degani notes that permanent interconnections and, thus, permanent electrical contacts have been made between the leads of semiconductor devices (components 12) and corresponding terminals (I/O contacts 14) of an individual circuit board (card site 33), whereas temporary contacts 43, which are to be used during testing or stressing of the circuit board and the semiconductor devices thereon, are provided at the edges of each individual circuit board.

In view of the foregoing, it is respectfully submitted that each of claims 1 through 9 and 11 through 20 comply with the definiteness requirement of 35 U.S.C. § 112, second paragraph. Accordingly, it is respectfully requested that the 35 U.S.C. § 112, second paragraph rejections of claims 1 thorough 9 and 11 through 20 be withdrawn.

# Rejections Under 35 U.S.C. § 103(a)

Claims 1 through 9 and 11 through 20 stand rejected under 35 U.S.C. § 103(a) for reciting subject matter which is assertedly unpatentable over the subject matter taught in Degani, in view of teachings from U.S. Patent 3,612,955 to Butherus et al. (hereinafter "Butherus"), and further in view of the Official Notice that the Office has taken.

The standard for establishing and maintaining a rejection under 35 U.S.C. § 103(a) is set forth in M.P.E.P. § 706.02(j), which provides:

To establish a *prima facie* case of obviousness, three basic criteria must be met. First, there must be some suggestion or motivation, either in the references themselves or in the knowledge generally available to one of ordinary skill in the art, to modify the reference or combine reference teachings. Second, there must be a reasonable expectation of success. Finally, the prior art reference (or references when combined) must teach or suggest all the claim limitations. The teaching or suggestion to make the claimed combination and the reasonable expectation of success must both be found in the prior art, and not based on applicant's disclosure. *In re Vaeck*, 947 F.2d 488, 20 USPQ2d 1438 (Fed. Cir. 1991).

Degani teaches circuit cards that include a plurality of unsingulated circuit boards. Each unsingulated circuit board is configured to receive multiple semiconductor devices. In addition to the circuit boards, the circuit cards of Degani include contacts at the edges of each circuit board to facilitate testing and stressing before final packaging of the semiconductor devices takes place and circuit boards are singulated from one another. *See, e.g.*, col. 4, lines 9-20.

Butherus teaches a circuit board that includes magnetized traces and a packaged semiconductor device that includes leads that are either magnetized or formed from a material which is attracted to the source of a magnetic field. Col. 2, lines 59-75. The traces and leads are magnetized in such a way that, with rough alignment of the packaged semiconductor device over

the circuit board, the magnetized leads will automatically align with their corresponding, complementarily magnetized traces. Col. 4, line 69, to col. 5, line 7.

Once the leads of the semiconductor device package are aligned with corresponding traces or terminals on the circuit board, the leads may be secured and electrically connected to their corresponding traces or terminals by known processes, such as by thermocompression bonding. Col. 2, lines 47-59.

The Office has taken official notice of two teachings. First, the Office has taken official notice that "it is well known in the art to provide ground and power to electronic components to energize them." Final Office Action dated December 15, 2003, page 3. Second, the Office has taken official notice that, "during burn-in testing[,] [sic] heat is provide[d] [sic] either cyclically or variously to purposely fail the [burned-in] component." *Id*.

Independent claim 1 is drawn to a method for establishing a temporary electrical contact with at least one semiconductor device. Temporary electrical contact is established in accordance with independent claim 1 by magnetically drawing at least one of a first member and a contact toward the other of the first member and the contact. As the temporary electrical contact is maintained, current may flow from at least one of the first member and the contact to the other of the contact and the first member.

Independent claim 8 recites a method for stress testing a plurality of semiconductor devices that are carried upon a common substrate and that are in communication with common ground and power contacts. The method of independent claim 8 includes establishing temporary electrical contact between a first member of an electrical connector and at least one common contact, with at least one of the first member and the at least one common contact being magnetically drawn toward the other to maintain the temporary electrical contact. While the temporary electrical contact is maintained, current is permitted to flow from at least one of the first member and the contact to the other of the contact and the first member.

It is respectfully submitted that there are several reasons that a *prima facie* case of obviousness under 35 U.S.C. § 103(a) has not been established against any of claims 1 through 9 or 11 through 20.

First, it is respectfully submitted that one of ordinary skill in the art would not have been motivated to combine the teachings of Degani and Butherus with the Official Notice that has been taken.

In this regard, Degani teaches circuit cards that include temporary contacts 43. Col. 4, lines 18-31. The temporary contacts 43 facilitate testing and stressing of semiconductor devices (components 12) that are carried upon unsingulated circuit boards (individual card sites 33) of the circuit cards of Degani. *Id.* The leads of the semiconductor devices (components 12) are electrically connected to corresponding terminals (I/O contacts 14) of the circuit boards by way of permanent interconnections. Col. 4, lines 15-18.

Butherus, in contrast, teaches a method in which magnetic attraction is used to align leads with contacts. Col. 4, line 69, to col. 5, line 7. Thereafter, the leads are permanently interconnected with the contacts. Col. 2, lines 47-59.

As the teachings of Butherus are limited to techniques for establishing permanent electrical contact, they would not be useful for establishing communication between temporary contacts of test or stress equipment and the temporary contacts 43 of Degani. Rather, the method of Butherus would only be useful for establishing permanent electrical contact between the leads of components 12 and corresponding I/O contacts 14 of individual card sites 33.

In view of the foregoing, it appears that the only source of motivation for one of ordinary skill in the art would be improper hindsight provided by the disclosure of the above-referenced application. Therefore, the teachings of Degani, Butherus, and the Office Notice that has been taken do not support a *prima facie* case of obviousness under 35 U.S.C. § 103(a) against any of claims 1 through 9 or 11 through 20.

Second, it is respectfully submitted that one of ordinary skill in the art would have no reason to expect the purported combination of teachings from Degani, Butherus, and the Official

Notice that has been taken to successfully result in the subject matter recited in any of claims 1 through 9 and 11 through 20.

The magnetic alignment and permanent interconnection method described in Butherus could not be used to establish a temporary electrical connection with the temporary contacts of the circuit cards that are taught in Degani.

As such, a *prima facie* case of obviousness under 35 U.S.C. § 103(a) has not been set forth against any of claims 1 through 9 or 11 through 20.

Third, it is respectfully submitted that a *prima facie* case of obviousness under 35 U.S.C. § 103(a) has not been established because Butherus teaches away from the asserted combination with teachings from Degani, as well as from the subject matter recited in claims 1 through 9 and 11 through 20.

Again, Degani teaches circuit cards that include temporary contacts 43 for facilitating temporary electrical connections that are used to test and stress components 12 that have been secured to individual card sites 33. Likewise, the methods of independent claims 1 and 8 include "establishing temporary electrical contact." The teachings of Butherus, in contrast, are limited to techniques that are used in establishing permanent electrical connections.

Thus, the Office has not established a *prima facie* case of obviousness under 35 U.S.C. § 103(a) against any of claims 1 through 9 or 11 through 20.

Fourth, it is respectfully submitted that Degani, Butherus, and the Official Notice that has been taken do not collectively or individually teaches or suggest each and every element of several claims.

With respect to the subject matter recited in independent claim 1, none of Degani, Butherus, or the Official Notice that has been taken teaches or suggests that current may flow from the leads to the terminals or vice-versa while a temporary, magnetic, electrical connection is maintained between the leads and the terminals. Degani and the Official Notice that has been taken do not provide any specifics as to how a temporary electrical connection may be established. The description of Butherus is limited to forming permanent (e.g.,

thermocompression) bonds between the terminals and leads prior to permitting electrical currents to flow from the leads to the terminals and from the terminals to the leads. *See* col. 2, lines 47-59. Further, while Butherus describes that leads of a packaged semiconductor device may be magnetically attracted to corresponding traces or terminals of a circuit board, Butherus lacks any teaching or suggestion that the magnetic attraction of the leads to the terminals is sufficient to electrically connect the leads to the traces or terminals. To the contrary, Butherus describes that additional securing of leads to traces or terminals, such as by thermocompression, is necessary. Col. 2, lines 47-59.

It is, therefore, respectfully submitted that Degani, Butherus, and the Office Notice that has been taken do not teach or suggest each and every element of independent claim 1, as would be required to maintain the 35 U.S.C. § 103(a).

Claims 2 through 7 are each allowable, among other reasons, for depending either directly or indirectly from claim 1, which is allowable.

Claim 4 is further allowable since each of the electrical connectors of Butherus, which are presumed to be the leads of the packaged semiconductor device, comprises only a single element. Thus, Butherus includes no teaching or suggestion of "positioning a second member of [an] electrical connector opposite [a] first member" of the electrical connector. Degani and the Official Notice that has been taken likewise lack any teaching or suggestion of this element of claim 4.

Claim 5 depends directly from claim 4 and is also allowable because none of Degani, Butherus, or the Official Notice that has been taken collectively or individually teaches or suggests that oppositely positioned first and second members of an electrical connector may be magnetically drawn to one another. The teachings of Butherus are instead limited to directly magnetically attracting a single-element lead to a trace or terminal.

Claim 6, which also depends directly from claim 4, is additionally allowable because none of Degani, Butherus, or the Official Notice that has been taken teaches or suggests securing both first and second members of an electrical connector to a substrate by magnetically attracting at least the first member of the electrical connector to a contact carried by the substrate. Butherus merely describes attracting single-element leads to corresponding magnetic traces or terminals.

With respect to the subject matter to which independent claim 8 is drawn, it is respectfully submitted that Degani, Butherus, and the Official Notice that has been taken do not provide any teaching or suggestion that one of a first member of an electrical connector and a contact may be magnetically drawn to the other to maintain a temporary electrical connection therebetween. Degani and the Official Notice that have been taken do not even suggest the use of a magnetic field. The teachings of Butherus are limited to generating a sufficient magnetic field to properly align leads of a packaged semiconductor device with corresponding traces or terminals of a circuit board. *See, e.g.*, col. 4, line 69, to col. 5, line 7. In addition, Butherus does not teach or suggest that an electric current may be permitted to flow from at least one of the leads and the terminals thereof to the other of the terminals and the leads thereof while temporary electrical contact is being maintained. Instead, the teachings of Butherus are limited to forming permanent electrical connections between leads and terminals before permitting electric current to flow from the terminals to the leads or vice-versa. *See* col. 2, lines 47-59.

Moreover, none of Degani, Butherus, or the Official Notice that has been taken includes any teaching or suggestion that temporary electrical contact may be established between a first member of an electrical connector and a contact, such as a power contact or a ground contact, which is *common to* a plurality of semiconductor devices. Nor has any art been cited in the Office Action which teaches or suggests that temporary electrical contact may be established between a first member of an electrical connector and a contact which is common to a plurality of semiconductor devices during stress testing.

Further, the mere fact that electrical connections are made during testing or stressing, as mentioned in Degani, does not inherently, or necessarily, lead to the conclusion that magnetic attraction of the type taught in Butherus would be adequate for establishing electrical connections that will withstand stress testing conditions, nor would one of ordinary skill in the art have any reason to expect that the type of magnetic attraction taught in Butherus could be successfully used for such a purpose.

For these reasons, it is respectfully submitted that the teachings of Butherus do not support a *prima facie* case of obviousness under 35 U.S.C. § 103(a) against independent claim 8.

Therefore, under 35 U.S.C. § 103(a), independent claim 8 is allowable over the teachings of Degani, Butherus, and the Official Notice that has been taken.

Each of claims 9 and 11 through 20 is allowable, among other reasons, for depending either directly or indirectly from claim 8, which is allowable.

Claim 11 is further allowable since each of the electrical connectors of Butherus, which are presumed to be the leads of the packaged semiconductor device, comprises only a single element. Thus, Butherus includes no teaching or suggestion of "positioning a second member of [an] electrical connector opposite [a] first member" of the electrical connector. Degani and the Official Notice that has been taken likewise lack any teaching or suggestion of "positioning a second member of [an] electrical connector opposite [a] first member" of the electrical connector.

Claim 12 depends directly from claim 11 and is also allowable because none of Degani, Butherus, or the Official Notice that has been taken teaches nor suggests that oppositely positioned first and second members of an electrical connector may be drawn to one another. Instead, the teachings or suggestions of Butherus are limited to attracting a single-element lead directly to a trace or terminal.

Claim 13, which depends directly from claim 12, is additionally allowable because Degani, Butherus, and the Official Notice that has been taken, taken together or separately, teaches or suggests that first and second members of an electrical connector may be magnetically drawn to one another.

Claim 14 is further allowable since Degani, Butherus, and the Official Notice that has been taken do not teach or suggest *securing* a first member of an electrical connector to a contact. Rather, Butherus merely teaches attracting single-element leads to corresponding magnetic traces or terminals. Securing of the leads to the traces or terminals is then effected by conventional bonding techniques, such as thermocompression. Col. 2, lines 47-59.

Claim 15 is additionally allowable because Degani, Butherus, and the Official Notice that has been taken neither teach nor suggest securing a first member of an electrical connector in position relative to a substrate. Again, Butherus teaches that any such securing is effected by conventional bonding techniques, such as thermocompression.

As a *prima facie* case of obviousness has not been established against any of claims 1 through 9 or 11 through 20, withdrawal of the 35 U.S.C. § 103(a) rejections of these claims is respectfully requested.

# **Election of Species Requirement**

As claim 8 is allowable and remains generic to all three species of invention that have been identified by the Office, as do claims 9 through 20, it is respectfully requested that claim 10 be returned to consideration and allowed.

#### CONCLUSION

It is respectfully submitted that each of claims 1 through 20 is allowable. An early notice of the allowability of each of these claims is respectfully solicited, as is an indication that the above-referenced application has been passed for issuance. If any issues preventing allowance of the above-referenced application remain which might be resolved by way of a telephone conference, the Office is kindly invited to contact the undersigned attorney.

Respectfully submitted,

Brick G. Power

Registration No. 38,581

Attorney for Applicant(s)

TRASKBRITT

P.O. Box 2550

Salt Lake City, Utah 84110-2550

Telephone: 801-532-1922

Date: July 29, 2004

BGP/sls:rmh
Document in ProLaw